TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

T C 7 M Z 2 4 5 F K

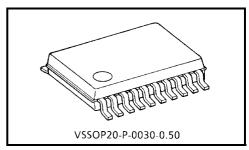
Low Voltage Octal Bus Transceiver with 5 V Tolerant Inputs and Outputs

The TC7MZ245FK is a high performance cmos octal bus transceiver. Designed for use in 3.3 V systems, it achieves high speed operation while maintaining the CMOS low power dissipation.

The device is designed for low-voltage (3.3 V) VCC applications, but it could be used to interface to 5 V supply environment for both inputs and outputs.

The direction of data transmission is determined by the level of the DIR input. The enable input (\overline{OE}) can be used to disable the device so that the busses are effectively isolated.

All inputs are equipped with protection circuits against static discharge.



Weight: 0.03 g (typ.)

Features

- Low voltage operation: $V_{CC} = 2.0 \sim 3.6 \text{ V}$
- High speed operation: $t_{pd} = 7.0 \text{ ns (max) (VCC} = 3.0 \sim 3.6 \text{ V)}$
- Output current: $|I_{OH}|/I_{OL} = 24 \text{ mA (min) (V}_{CC} = 3.0 \text{ V)}$
- Latch-up performance: ±500 mA
- Package: VSSOP (US20)
- Bidirectional interface between 3.3 V and 5.0 V signals.
- Power down protection is provided on all inputs and outputs.
- Pin and function compatible with the 74 series (74AC/VHC/HC/F/ALS/LS etc.) 245 type.

Note: Do not apply a signal to any bus terminal when it is in the output mode. Damage may result.

All floating (high impedance) bus terminals must have their input levels fixed by means of pull up or pull down resistors.

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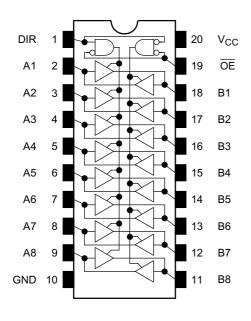
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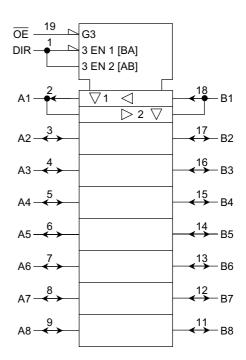
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Pin Assignment (top view)



IEC Logic Symbol



Truth Table

Inputs		Outputs	Function		
ŌĒ	DIR	Outputs	A-Bus	B-Bus	
L	L	A = B	Output	Input	
L	Н	B = A Input		Output	
Н	Х	Z	High Impedance		

X: Don't care

Z: High impedance



Maximum Ratings

Characteristics	Symbol	Rating	Unit
Supply voltage range	V _{CC}	-0.5~7.0	V
DC input voltage (DIR, OE)	V _{IN}	-0.5~7.0	V
DC bus I/O voltage	Vivo	-0.5~7.0 (Note1)	V
DC bus I/O voltage	V _{I/O}	-0.5~V _{CC} + 0.5 (Note2)	V
Input diode current	I _{IK}	-50	mA
Output diode current	lok	±50 (Note3)	mA
DC output current	Гоит	±50	mA
Power dissipation	PD	180	mW
DC V _{CC} /ground current	I _{CC} /I _{GND}	±100	mA
Storage temperature	T _{stg}	-65~150	°C

Note1: Output in off-state

Note2: High or low state. IOUT absolute maximum rating must be observed.

Note3: $V_{OUT} < GND, V_{OUT} > V_{CC}$

Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit	
Supply voltage	V _{CC}	2.0~3.6	V	
Supply voltage	VCC	1.5~3.6 (Note4)		
Input voltage (DIR, $\overline{\sf OE}$)	V _{IN}	0~5.5	V	
Bus I/O voltage	V _{I/O}	0~5.5 (Note5)	V	
Bus 1/O voltage	V I/O	0~V _{CC} (Note6)	V	
Output current	I _{OH} /I _{OI}	±24 (Note7)	mA	
Output current	'OH/'OL	±12 (Note8)	IIIA	
Operating temperature	T _{opr}	-40~85	°C	
Input rise and fall time	dt/dv	0~10 (Note9)	ns/V	

Note4: Data retention only

Note5: Output in off-state

Note6: High or low state

Note7: $V_{CC} = 3.0 \sim 3.6 \text{ V}$

Note8: $V_{CC} = 2.7 \sim 3.0 \text{ V}$

Note9: $V_{IN} = 0.8 \sim 2.0 \text{ V}, V_{CC} = 3.0 \text{ V}$



Electrical Characteristics

DC Characteristics ($Ta = -40 \sim 85$ °C)

Characteristics		Symbol	Test Condition		Min	Max	Unit	
					V _{CC} (V)			
Input voltage	High level	V_{IH}		_	2.7~3.6	2.0		V
input voitage	Low level	V_{IL}		_	2.7~3.6	_	0.8	V
				$I_{OH} = -100 \mu A$	2.7~3.6	V _{CC} - 0.2		
	High level	V _{OH}	$V_{IN} = V_{IH}$ or V_{IL}	$I_{OH} = -12 \text{ mA}$	2.7	2.2	_	
				I _{OH} = -18 mA	3.0	2.4	_	v .
Output voltage				$I_{OH} = -24 \text{ mA}$	3.0	2.2	_	
	Landani	V _{OL}	$V_{IN} = V_{IH} \text{ or } V_{IL}$	I _{OL} = 100 μA	2.7~3.6	_	0.2	
				I _{OL} = 12 mA	2.7	_	0.4	
	Low level			I _{OL} = 16 mA	3.0	_	0.4	
				I _{OL} = 24 mA	3.0	_	0.55	
Input leakage current		I _{IN}	V _{IN} = 0~5.5 V		2.7~3.6	_	±5.0	μΑ
3-state output off-state current		lo-	$V_{IN} = V_{IH}$ or V_{IL}		2.7~3.6	_	±5.0	μА
		I _{OZ}	V _{OUT} = 0~5.5 V		2.7~3.0	_	±5.0	
Power off leakag	ge current	l _{OFF}	$V_{IN}/V_{OUT} = 5.5 \text{ V}$		0	_	10.0	μΑ
Quiescent supply current		laa	V _{IN} = V _{CC} or GND		2.7~3.6	_	10.0	
		Icc	V _{IN} /V _{OUT} = 3.6~5.5 V		2.7~3.6	_	±10.0	μΑ
Increase in I _{CC} per input ΔI _C		ΔI_{CC}	$V_{IH} = V_{CC} - 0.6 V$ 2.7~3.6		2.7~3.6	_	500	



AC Characteristics ($Ta = -40 \sim 85$ °C)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Min	Max	Unit
Dronogation delay time	t _{pLH}	Figure 1, Figure 2	2.7	_	8.0	20
Propagation delay time	t _{pHL}	Figure 1, Figure 2	3.3 ± 0.3	1.5	7.0	ns
Output enable time	t _{pZL}	Figure 1, Figure 3	2.7	_	9.5	ns
Output enable time	t _{pZH}	Tigale 1, Figure 0	3.3 ± 0.3	1.5	8.5	113
Output disable time	t _{pLZ}	Figure 1, Figure 3	2.7	_	8.5	ns
Output disable time	t _{pHZ}	rigure 1, rigure 3	3.3 ± 0.3	1.5	7.5	10
Output to output skew	t _{osLH}	(Note10)	2.7	_		ns
Output to output skew	t _{osHL}	(Note 10)	3.3 ± 0.3	_	1.0	10

Note10: This parameter is guaranteed by design.

 $(t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSHL} = |t_{PHLm} - t_{PHLn}|)$

Dynamic Switching Characteristics

(Ta = 25°C, Input: $t_r = t_f = 2.5$ ns, $C_L = 50$ pF, $R_L = 500$ Ω)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
Quiet output maximum dynamic V _{OL}	V_{OLP}	$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	3.3	8.0	V
Quiet output minimum dynamic V _{OL}	V _{OLV}	$V_{IH} = 3.3 \text{ V}, V_{IL} = 0 \text{ V}$	3.3	8.0	V

Capacitive Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	V _{CC} (V)	Тур.	Unit
Input capacitance	C _{IN}	DIR, OE	3.3	7	pF
Bus input capacitance	C _{I/O}	A _n , B _n	3.3	8	pF
Power dissipation capacitance	C _{PD}	f _{IN} = 10 MHz (Note11	3.3	25	pF

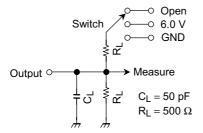
Note11: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8 (per bit)$



AC Test Circuit



Paramenter	Switch
t _{pLH} , t _{pHL}	Open
t_{pLZ} , t_{pZL}	6.0 V
t _{pHZ} , t _{pZH}	GND

Figure 1

AC Waveform

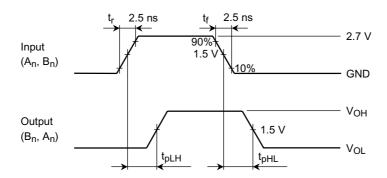


Figure 2 t_{pLH} , t_{pHL}

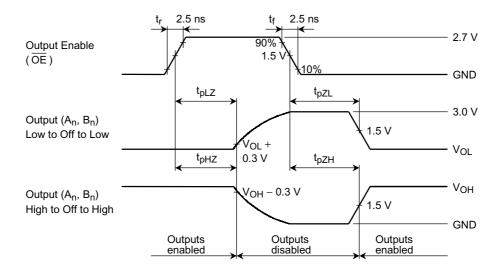
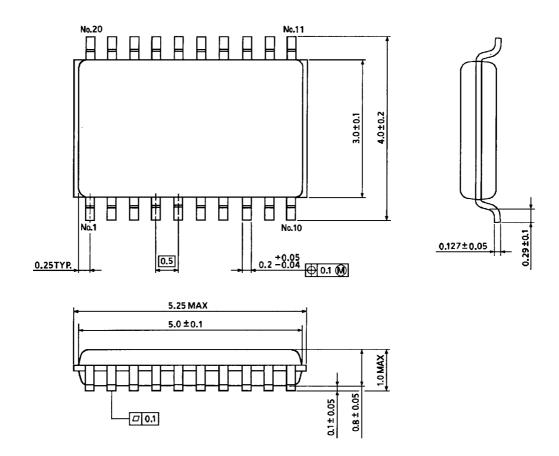


Figure 3 t_{pLZ} , t_{pHZ} , t_{pZL} , t_{pZH}

Package Dimensions



Weight: 0.03 g (typ.)